

05

Notice of References Cited	Application/Control No. 09/366,749	Applicant(s)/Patent Under Reexamination VOIGT ET AL.	
	Examiner Sam Rimell	Art Unit 2166	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification	
	A	US-5832450-	11-1998	Myers et al.	705	3
	B	US-6067547-	05-2000	Douceur	707	100
	C	US-6163781-	12-2000	Wess, Jr.	705	2
	D	US-6168563-B1	01-2001	Brown	705	2
	E	US-5940659-	08-1999	Lancelot et al.	705	3
	F	US-5644764-	07-1997	Johnson et al.	707	103
	G	US- -				
	H	US- -				
	I	US- -				
	J	US- -				
	K	US- -				
	L	US- -				
	M	US- -				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification	
	N	- -					
	O	- -					
	P	- -					
	Q	- -					
	R	- -					
	S	- -					
	T	- -					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	Examiner Sam Rimell	Art Unit 2175	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6401138	06-2002	Judge et al.	709/328
	B	US-6385589	05-2002	Trusheim et al.	705/2
	C	US-5668998	09-1997	Mason et al.	709/328
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.